Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/562,408	Reexamination YOU ET AL.	
Examiner	Art Unit	
Anne Marie S. Wehbe	1633	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,250,846	10-1993	Kondo, Toshihiko	257/756
*	В	US-6,468,793	10-2002	Teem, John L.	435/325
	O	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	н	US-		-	
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN FATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 01/32898	05-2001	wo	Yonemitsu et al.	
	0	·				
	Р	·				
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		
	v		
	w		
	×		

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.